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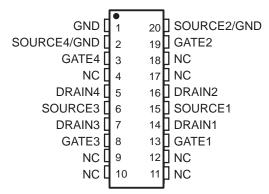
- Low r_{DS(on)} . . . 0.4 Ω Typ
- High-Voltage Output . . . 60 V
- Pulsed Current . . . 3 A Per Channel
- Fast Commutation Speed
- Direct Logic-Level Interface

description

The TPIC5424L is a monolithic logic-level power DMOS array that consists of four electrically isolated N-channel enhancement-mode DMOS transistors, two of which are configured with a common source.

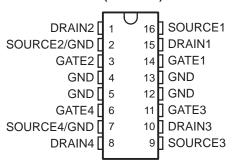
The TPIC5424L is offered in a 16-pin thermally enhanced dual-in-line (NE) package and a 20-pin wide-body surface-mount (DW) package. The TPIC5424L is characterized for operation over the case temperature range of -40° C to 125°C.

DW PACKAGE (TOP VIEW)

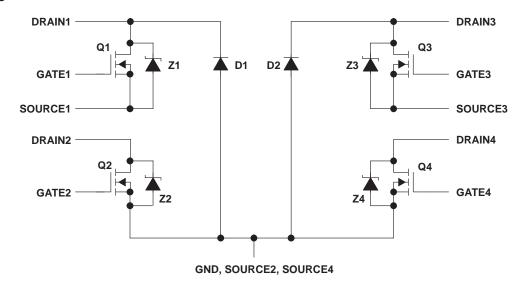


NC - No internal connection

NE PACKAGE (TOP VIEW)



schematic



TPIC5424L H-BRIDGE LOGIC-LEVEL POWER DMOS ARRAY

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absolute maximum ratings over operating case temperature range (unless otherwise noted)[†]

Drain-to-source voltage, V _{DS}
Source-to-GND voltage (Q1, Q3)
Drain-to-GND voltage (Q1, Q3)
Drain-to-GND voltage (Q2, Q4)
Gate-to-source voltage, V _{GS} ±20 V
Continuous drain current, each output, T _C = 25°C
Continuous source-to-drain diode current, T _C = 25°C
Pulsed drain current, each output, I _{max} , T _C = 25°C (see Note 1 and Figure 15) 3 A
Single-pulse avalanche energy, E _{AS} , T _C = 25°C (see Figure 4)
Continuous total dissipation
Operating virtual junction temperature range, T _J –40°C to 150°C
Operating case temperature range, T _C –40°C to 125°C
Storage temperature range –65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: Pulse duration = 10 ms and duty cycle = 2%.

DISSIPATION RATING TABLE

PACKAGE	T _C ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _C = 25°C	T _C = 125°C POWER RATING	
DW	1389 mW	11.1 mW/°C	279 mW	
NE	2075 mW	16.6 mW/°C	415 mW	

electrical characteristics, $T_C = 25^{\circ}C$ (unless otherwise noted)

PARAMETER		TEST COND	MIN	TYP	MAX	UNIT	
V _{(BR)DSX}	Drain-to-source breakdown voltage	I _D = 250 μA,	V _{GS} = 0	60			V
V _{GS(th)}	Gate-to-source threshold voltage	I _D = 1 mA, See Figure 5	$V_{DS} = V_{GS}$	1.5	1.85	2.2	V
V _(BR)	Reverse drain-to-GND breakdown voltage (across D1, D2)	Drain-to-GND current = 250 μA		100			٧
V _{DS(on)}	Drain-to-source on-state voltage	I _D = 1 A, See Notes 2 and 3	VGS = 5 V,		0.4	0.48	٧
V _F (SD)	Forward on-state voltage, source-to-drain	I _S = 1 A, V _{GS} = 0 (Z1, Z2, Z3, Z4), See Notes 2 and 3 and Figure 12			1	1.2	٧
V _F	Forward on-state voltage, GND-to-drain	I _D = 1 A (D1, D2), See Notes 2 and 3			4.6		V
lana	Zara gata valtaga drain aurrant	V _{DS} = 48 V,	T _C = 25°C		0.05	1	^
IDSS	Zero-gate-voltage drain current	$V_{GS} = 0$	T _C = 125°C		0.5	10	μΑ
IGSSF	Forward gate current, drain short circuited to source	V _{GS} = 5 V,	V _{DS} = 0		10	100	nA
IGSSR	Reverse gate current, drain short circuited to source	V _{SG} = 5 V,	V _{DS} = 0		10	100	nA
I	Leakage current drain to CND	V _{DGND} = 48 V	T _C = 25°C		0.05	1	
l _{lkg}	Leakage current, drain-to-GND	(D1, D2)	T _C = 125°C		0.5		μΑ
*****	Static drain-to-source on-state resistance	V _{GS} = 5 V, I _D = 1 A,		0.4	0.48	Ω	
rDS(on)	Static drain-to-source on-state resistance	See Notes 2 and 3 and Figures 6 and 7	T _C = 125°C		0.65	0.68	52
9fs	Forward transconductance	V _{DS} = 15 V, See Notes 2 and 3 a	$I_D = 0.5 A$, nd Figure 9	1.25	1.39		S
C _{iss}	Short-circuit input capacitance, common source				220	275	
C _{oss}	Short-circuit output capacitance, common source	$V_{DS} = 25 V$,			120	150	pF
C _{rss}	Short-circuit reverse-transfer capacitance, common source	f = 1 MHz,	See Figure 11		100	125	pΓ

NOTES: 2. Technique should limit $T_J - T_C$ to 10°C maximum.

source-to-drain and GND-to-drain diode characteristics, $T_C = 25^{\circ}C$

PARAMETER TEST			T CONDITIONS		MIN	TYP	MAX	UNIT		
				Z1 and Z3		55				
t _{rr}	Reverse-recovery time	I _S =0.5 A, V _{GS} = 0, See Figures 1 and 14				Z2 and Z4		150		ns
			$= 0,$ di/dt = 100 A/ μ s,	D1 and D2		200				
	See Figures 1 and 14			Z1 and Z3		0.06				
Q _{RR} Total diode charge			Z2 and Z4		0.3		μС			
			D1 and D2		0.7					

^{3.} These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

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resistive-load switching characteristics, T_C = 25°C

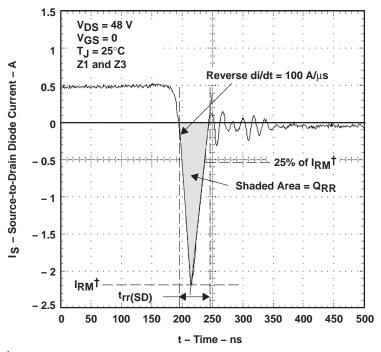
	PARAMETER		TEST CONDITIONS				MAX	UNIT
td(on)	Turn-on delay time					34	68	
td(off)	Turn-off delay time	$V_{DD} = 25 \text{ V},$		t _{en} = 10 ns,		40	82	
t _r	Rise time	$t_{dis} = 10 \text{ ns},$				21	42	ns
tf	Fall time	1				25	50	
Qg	Total gate charge					3.9	5	
Q _{gs(th)}	Threshold gate-to-source charge	V _{DS} = 48 V, See Figure 3	$I_D = 1 A$,	$V_{GS} = 10 V$		0.55	8.0	nC
Q _{gd}	Gate-to-drain charge	occ rigaic c				2.5	3.6	
LD	Internal drain inductance					5		- LI
LS	Internal source inductance					5		nΗ
Rg	Internal gate resistance					0.25		Ω

thermal resistance

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT			
р	Junction-to-ambient thermal resistance		Junction-to-ambient thermal resistance DW package				90		°C/W
КөЈА	R _θ JA (see Note 4)	NE package	All autoute with a suel seven		60] C/VV		
R ₀ JP Junction-to-pin thermal resistance	lunction to air thousand ancietance	DW package	All outputs with equal power		30		0CAM		
	Junction-to-pin thermal resistance	NE package			25		°C/W		

NOTE 4: Package mounted on an FR4 printed-circuit board with no heat sink

PARAMETER MEASUREMENT INFORMATION



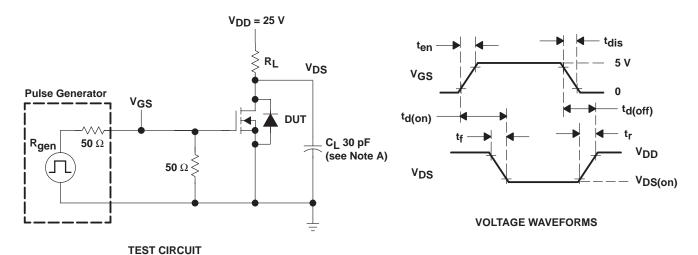
[†] I_{RM} = maximum recovery current

NOTE A. The above waveform is representative of Z2, Z4, D1, and D2 in shape only.

Figure 1. Reverse-Recovery-Current Waveform of Source-to-Drain Diode



PARAMETER MEASUREMENT INFORMATION



NOTE A: C_L includes probe and jig capacitance.

Figure 2. Resistive-Switching Test Circuit and Voltage Waveforms

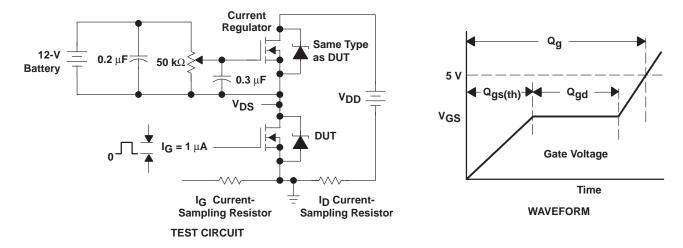
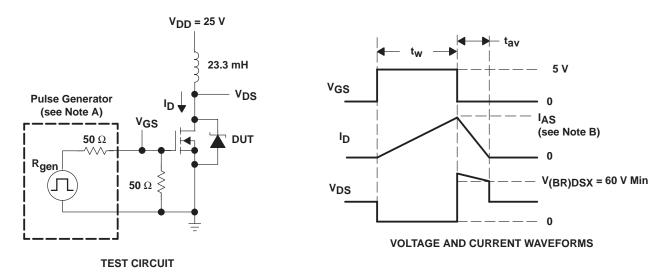


Figure 3. Gate-Charge Test Circuit and Waveform

PARAMETER MEASUREMENT INFORMATION



NOTES: A. The pulse generator has the following characteristics: $t_r \le 10$ ns, $t_f \le 10$ ns, $Z_O = 50$ Ω .

B. Input pulse duration (t_W) is increased until peak current $I_{AS} = 3$ A.

Energy test level is defined as
$$E_{AS} = \frac{I_{AS} \times V_{(BR)DSX} \times t_{av}}{2} = 180 \text{ mJ}.$$

Figure 4. Single-Pulse Avalanche-Energy Test Circuit and Waveforms

TYPICAL CHARACTERISTICS

GATE-TO-SOURCE THRESHOLD VOLTAGE JUNCTION TEMPERATURE 2.5 V_{GS(th)} - Gate-to-Source Threshold Voltage - V $V_{DS} = V_{GS}$ 2 $I_D = 1 \text{ mA}$ 1.5 $I_D = 100 \mu A$ 1 0.5 -40 - 2040 60 80 100 120 140 160 T_J - Junction Temperature - °C

Figure 5

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE

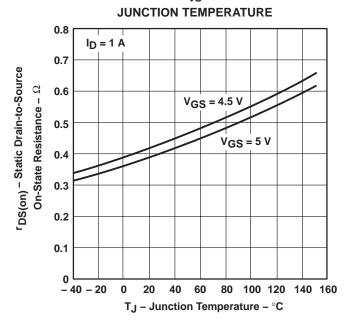


Figure 6

DRAIN CURRENT

DRAIN-TO-SOURCE VOLTAGE

TYPICAL CHARACTERISTICS

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE

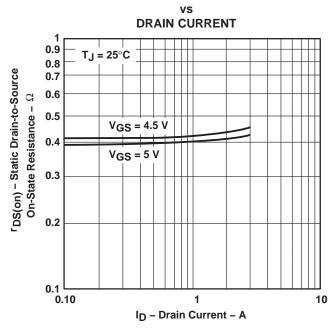


Figure 7

ΔV_{GS} = 0.2 V T_J = 25°C

Figure 8

8 10

V_{DS} - Drain-to-Source Voltage - V

12

14 16

18 20

0

2

DISTRIBUTION OF FORWARD TRANSCONDUCTANCE

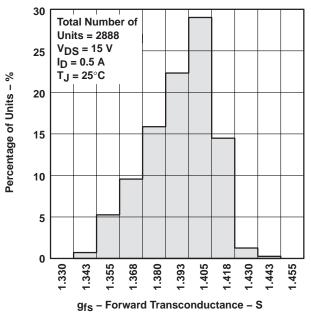


Figure 9

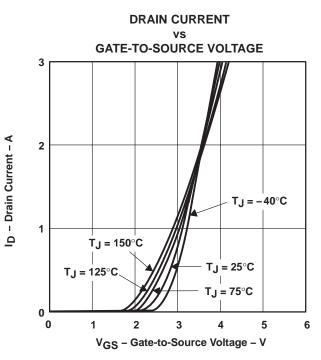


Figure 10

TYPICAL CHARACTERISTICS

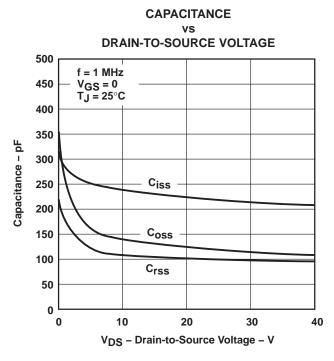


Figure 11

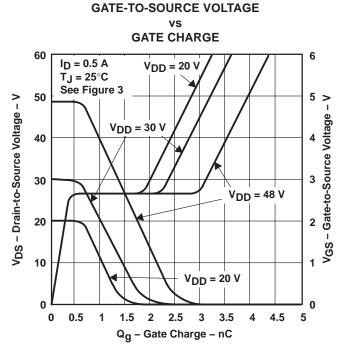


Figure 13

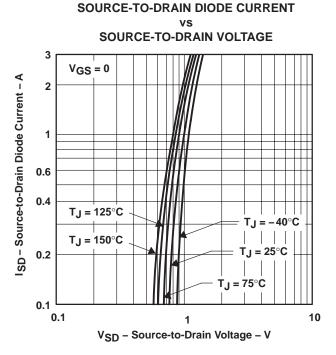


Figure 12

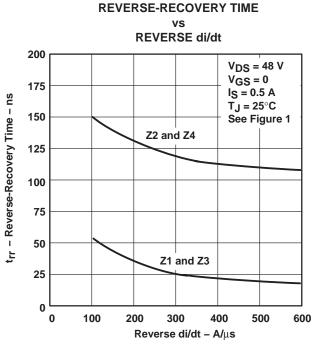
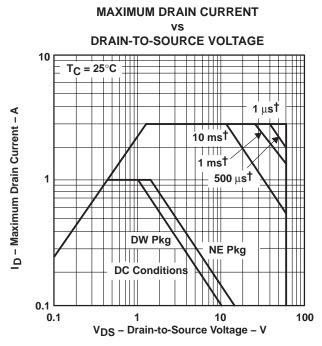


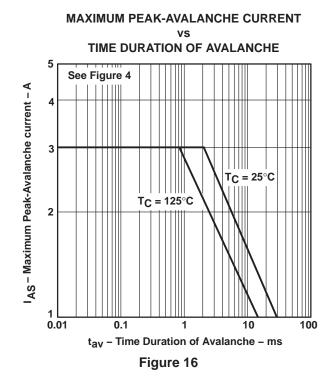
Figure 14

THERMAL INFORMATION



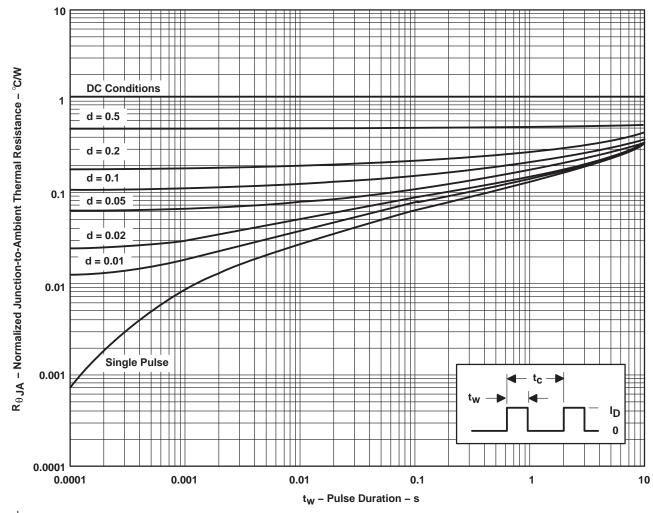
†Less than 2% duty cycle

Figure 15



THERMAL INFORMATION

NE PACKAGE[†] NORMALIZED JUNCTION-TO-AMBIENT THERMAL RESISTANCE vs PULSE DURATION



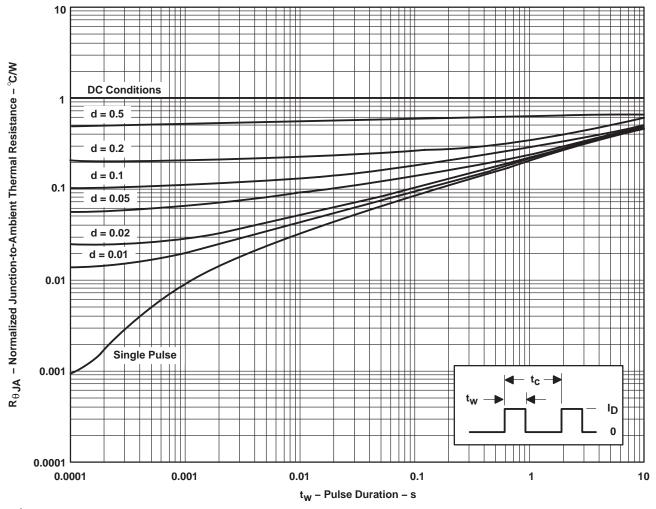
† Device mounted on FR4 printed-circuit board with no heat sink

 $\begin{aligned} \text{NOTES:} \quad Z_{\theta A}(t) &= r(t) \; R_{\theta JA} \\ \quad t_W &= \text{pulse duration} \\ \quad t_C &= \text{cycle time} \\ \quad d &= \text{duty cycle} = t_W/t_C \end{aligned}$

Figure 17

THERMAL INFORMATION

DW PACKAGE[†] NORMALIZED JUNCTION-TO-AMBIENT THERMAL RESISTANCE vs PULSE DURATION



† Device mounted on FR4 printed-circuit board with no heat sink

 $\begin{aligned} \text{NOTES:} \quad Z_{\theta A}(t) &= r(t) \; R_{\theta JA} \\ \quad t_W &= \text{pulse duration} \\ \quad t_C &= \text{cycle time} \\ \quad d &= \text{duty cycle} = t_W/t_C \end{aligned}$

Figure 18



PACKAGE OPTION ADDENDUM

8-Apr-2005

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
TPIC5424LDW	OBSOLETE	SOIC	DW	20	TBD	Call TI	Call TI
TPIC5424LNE	OBSOLETE	PDIP	NE	16	TBD	Call TI	Call TI

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

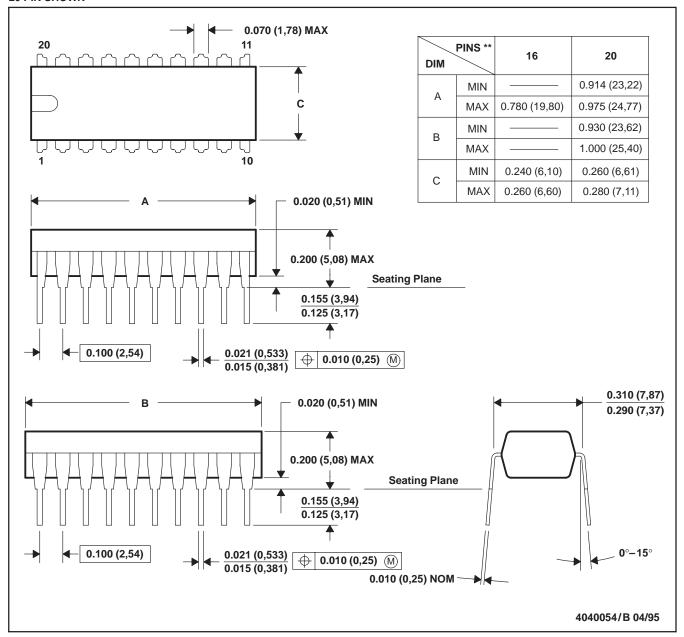
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NE (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

20 PIN SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Falls within JEDEC MS-001 (16 pin only)



SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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